FORM PTO 1449 (*modified*) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)	ATTY DOCKET NO. **03500.017619.**	APPLICATION NO. **10/679,386**
	APPLICANT **Mahito Shinohara**	
	FILING DATE **October 07, 2003**	GROUP **Not Yet Assigned**

OIPE JC73
DEC 29 2004
PATENT & TRADEMARK OFFICE

U.S. PATENT DOCUMENTS

*EXAMINER		DOCUMENT					FILING DATE

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
/S.E./		**2000-78475**	**03/14/00**	**Japan**			**Abstract**

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

/S.E./		**Chinese Office Action, dated October 21, 2004, issued in foreign counterpart Application 2003101000532 (2 pages with 2 page attachment).**

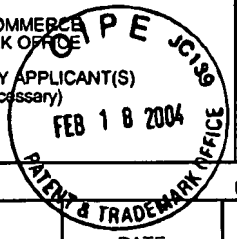
EXAMINER /Scott Egan/ DATE CONSIDERED 05/14/2007

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

FORM PTO 1449 (*modified*)

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

LIST OF REFERENCES CITED BY APPLICANT(S)
(Use several sheets if necessary)



ATTY DOCKET NO. 03500.017619.	APPLICATION NO. 10/679,386
APPLICANT Mahito Shinohara	
FILING DATE October 07, 2003	GROUP Not Yet Assigned

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
/S.E./		5,587,738	12/24/96	Shinohara	348	302	
/S.E./		6,300,615 B1	10/09/01	Shinohara	250	214	
/S.E./		Re. 34,309	07/13/93	Tanaka et al.	358	213.31	
/S.E./		5,288,988	02/22/94	Hashimoto et al.	250	208.1	
/S.E./		5,424,529	06/13/95	Hashimoto et al.	250	208.1	
/S.E./		5,698,844	12/16/97	Shinohara et al.	250	214	
/S.E./		2002/0024068 A1	02/28/02	Shinohara	257	225	

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
/S.E./		2000078474	03/14/00	Japan			Abstract

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

/S.E./		Yusa, A., et al. *SIT Image Sensor: Design Considerations and Characteristics*, 33 IEEE Transactions on Electronic Devices, No. 6 June 1986 pp. 735-742
/S.E./		Nakamura et al., *Gate Accumulation Type mos Phototransistor Image Sensor*, 41 Proceedings of the Institute of Television Engineers of Japan, No. 11 November 1987, pp. 1075-1082
/S.E./		Mendis, S.K., et al. *A 128x128 CMOS Active Pixel Image Sensor for Highly Integrated Imaging Systems*, IEDM Technical Digest 1993 pp. 583-586
/S.E./		Tanaka, N., *A 310k Pixel Bipolar Imager (BASIS)*, 36th IEEE International Solid State Circuits Conference, Feb. 15-17 1989 pp. 96-97

EXAMINER /Scott Egan/ DATE CONSIDERED 05/14/2007

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.